



# Power MOSFETS

## DATASHEET

**LM60025NAP3A**

N-Channel  
Enhancement Mode MOSFET

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Quality Management Systems  
ISO 9001:2015 Certificate

## N-Channel Enhancement Mode MOSFET

### Pin Description

TO-220-3L(TOP view)	Symbol	Symbol	N-Channel	Unit
			V <sub>DSS</sub>	60
			R <sub>DS(ON)-Max</sub>	3
			I <sub>D</sub>	204

### Feature

- Fast switching speed
- Reliable and Rugged
- ROHS Compliant & Halogen-Free
- 100% UIS and Rg Tested

### Product Summary

- Switching and Synchronous Rectification
- BLDC

### Ordering Information

Orderable Part Number	Package Type	Form	Shipping	Marking
LM60025NAP3A	TO-220-3L	Tube	50 / Tube	60025 □□□□□

Note : □□□□□□ = Lot Code

### Absolute Maximum Ratings (T<sub>J</sub>=25°C Unless Otherwise Noted)

Symbol	Parameter	N-Channel	Unit
V <sub>DSS</sub>	Drain-Source Voltage	60	V
V <sub>GSS</sub>	Gate-Source Voltage	±20	
T <sub>J</sub>	Maximum Junction Temperature	150	°C
T <sub>STG</sub>	Storage Temperature Range	-55 to 150	°C
I <sub>S</sub>	Diode Continuous Forward Current	T <sub>c</sub> =25°C 114	A
I <sub>DM</sub> <sup>①</sup>	Pulse Drain Current Tested	T <sub>c</sub> =25°C 400	A
I <sub>D</sub>	Continuous Drain Current	T <sub>c</sub> =25°C 204 <sup>①</sup> T <sub>c</sub> =100°C 129	A
P <sub>D</sub>	Maximum Power Dissipation	T <sub>c</sub> =25°C 125 T <sub>c</sub> =100°C 50	W
I <sub>D</sub>	Continuous Drain Current	T <sub>A</sub> =25°C 26 T <sub>A</sub> =70°C 21	A
P <sub>D</sub>	Maximum Power Dissipation	T <sub>A</sub> =25°C 2.0 T <sub>A</sub> =70°C 1.3	W
I <sub>AS</sub> <sup>②</sup>	Avalanche Current, Single pulse	L=0.1mH 51 L=0.5mH 27	A
E <sub>AS</sub> <sup>②</sup>	Avalanche Energy, Single pulse	L=0.1mH 130 L=0.5mH 182	mJ

### Thermal Characteristics

Symbol	Parameter	Rating	Unit
R <sub>θJC</sub>	Thermal Resistance-Junction to Case	Steady State 1	°C/W
R <sub>θJA</sub> <sup>③</sup>	Thermal Resistance-Junction to Ambient	Steady State 62.5	°C/W

Note ① : Max. current is limited by junction temperature

Note ② : UIS tested and pulse width are limited by maximum junction temperature 150°C

Note ③ : Surface Mounted on 1in<sup>2</sup> FR-4 board with 1oz

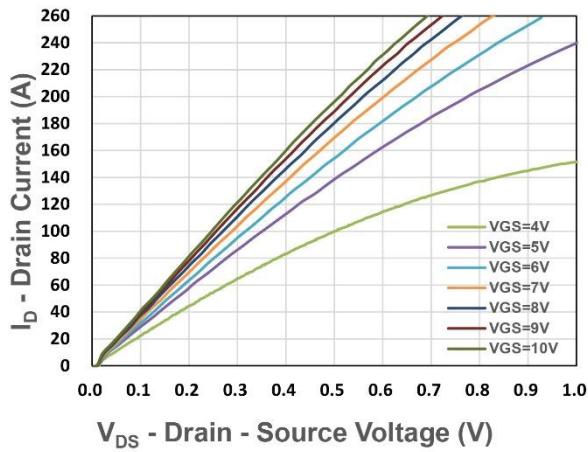
N-Channel Electrical Characteristics ( $T_J=25^\circ\text{C}$  Unless Otherwise Noted)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
<b>Static Electrical Characteristics</b>						
$\mathbf{BV_{DSS}}$	Drain-Source Breakdown Voltage	$V_{GS}=0\text{V}, I_{DS}=250\mu\text{A}$	60	-	-	V
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS}=48\text{V}, V_{GS}=0\text{V}$	-	-	1	$\mu\text{A}$
$V_{GS(\text{th})}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_{DS}=250\mu\text{A}$	1	1.7	2.5	V
$I_{GSS}$	Gate Leakage Current	$V_{GS}=\pm 20\text{V}, V_{DS}=0\text{V}$	-	-	$\pm 100$	$\text{nA}$
$R_{DS(\text{ON})}^{\text{(4)}}$	Drain-Source On-state Resistance	$V_{GS}=10\text{V}, I_{DS}=20\text{A}$	-	2.5	3.0	$\text{m}\Omega$
		$V_{GS}=4.5\text{V}, I_{DS}=10\text{A}$		3.5	4.6	
$g_{fs}$	Forward Transconductance	$V_{DS}=5\text{V}, I_{DS}=10\text{A}$	-	36	-	S
<b>Dynamic Characteristics <sup>(5)</sup></b>						
$R_G$	Gate Resistance	$V_{GS}=0\text{V}, V_{DS}=0\text{V},$ Freq.=1MHz	-	0.76	-	$\Omega$
$C_{iss}$	Input Capacitance	$V_{GS}=0\text{V},$ $V_{DS}=30\text{V},$ Freq.=1MHz	-	5155	-	$\text{pF}$
$C_{oss}$	Output Capacitance		-	1331	-	
$C_{rss}$	Reverse Transfer Capacitance		-	195	-	
$t_{d(\text{ON})}$	Turn-on Delay Time	$V_{GS}=10\text{V}, V_{DS}=25\text{V},$ $I_D=1\text{A}, R_{\text{GEN}}=3\Omega$	-	16	-	$\text{nS}$
$t_r$	Turn-on Rise Time		-	5.6	-	
$t_{d(\text{OFF})}$	Turn-off Delay Time		-	54	-	
$t_f$	Turn-off Fall Time		-	102	-	
$Q_g$	Total Gate Charge	$V_{GS}=4.5\text{V}, V_{DS}=30\text{V}$ $I_D=20\text{A}$	-	45	-	$\text{nC}$
$Q_g$	Total Gate Charge	$V_{GS}=10\text{V}, V_{DS}=30\text{V},$ $I_D=20\text{A}$	-	93.7	-	
$Q_{gs}$	Gate-Source Charge		-	20.4	-	
$Q_{gd}$	Gate-Drain Charge		-	20.5	-	
<b>Source-Drain Characteristics</b>						
$V_{SD}^{\text{(4)}}$	Diode Forward Voltage	$I_{SD}=10\text{A}, V_{GS}=0\text{V}$	-	0.8	1.1	V
$t_{rr}$	Reverse Recovery Time	$I_F=10\text{A}, V_R=48\text{V}$	-	45	-	$\text{nS}$
$Q_{rr}$	Reverse Recovery Charge		-	43	-	$\text{nC}$

Note ④ : Pulse test (pulse width $\leq 300\text{us}$ , duty cycle $\leq 2\%$ ).

Note ⑤ : Guaranteed by design, not subject to production testing.

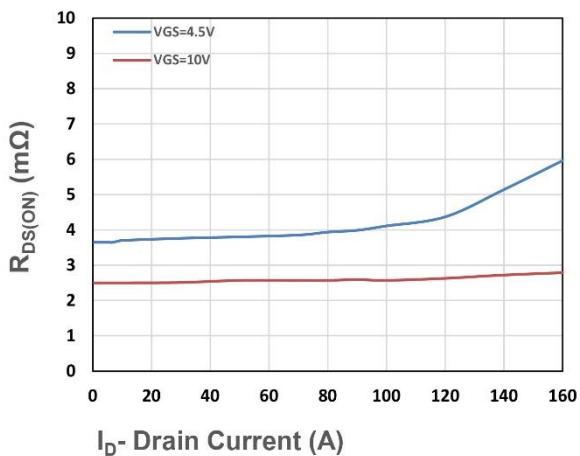
## N-Channel Typical Characteristics



$I_D$  - Drain Current (A)

$V_{DS}$  - Drain - Source Voltage (V)

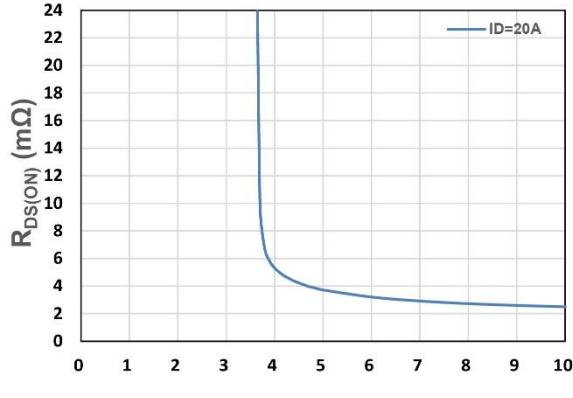
Figure 1. Output Characteristics



$R_{DS(ON)}$  (mΩ)

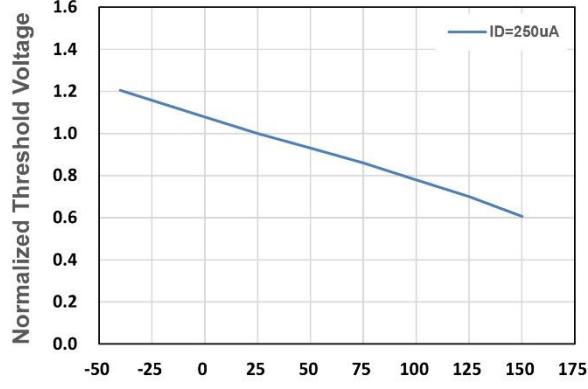
$I_D$  - Drain Current (A)

Figure 2. On-Resistance vs. ID



$V_{GS}$  - Gate - Source Voltage (V)

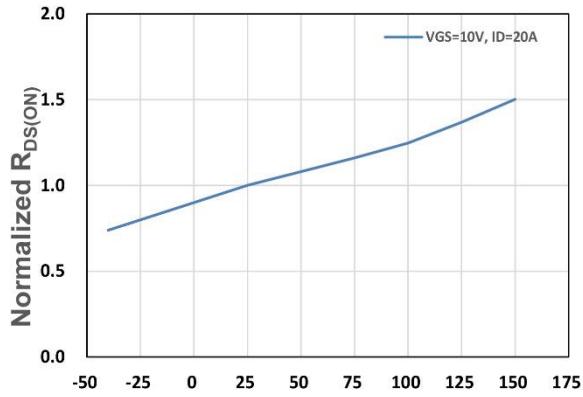
Figure 3. On-Resistance vs. VGS



Normalized Threshold Voltage

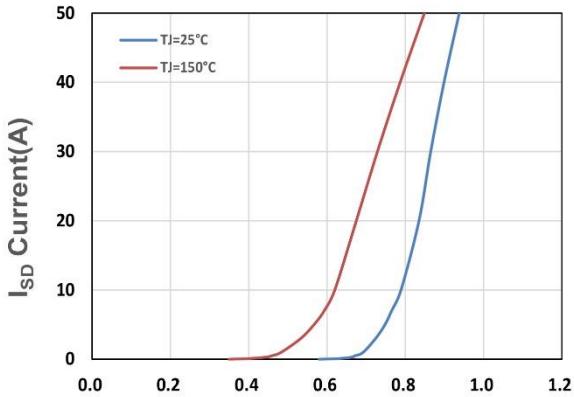
$T_j$ , Junction Temperature(°C)

Figure 4. Gate Threshold Voltage



$T_j$  , Junction Temperature(°C)

Figure 5. Drain-Source On Resistance

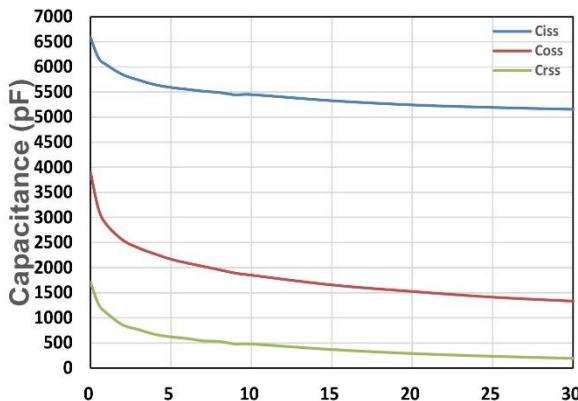


$I_{SD}$  Current(A)

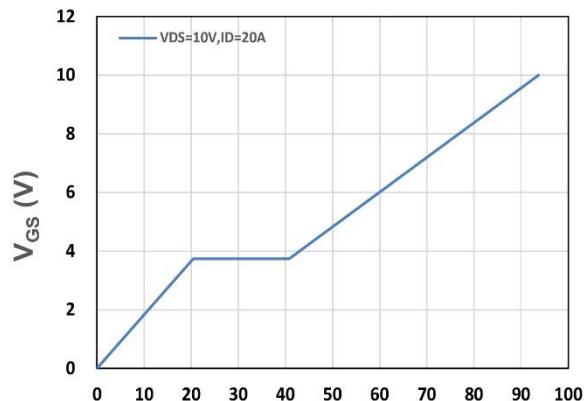
$V_{SD}$ , Source-Drain Voltage(V)

Figure 6. Source-Drain Diode Forward

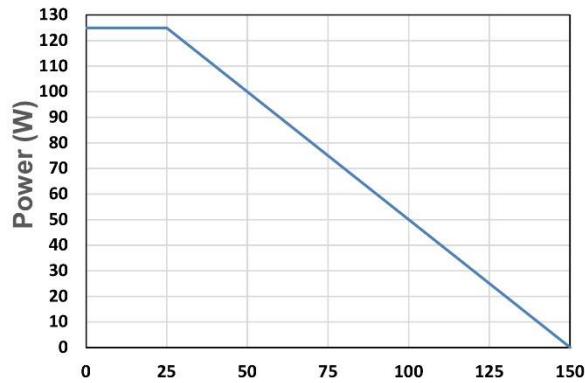
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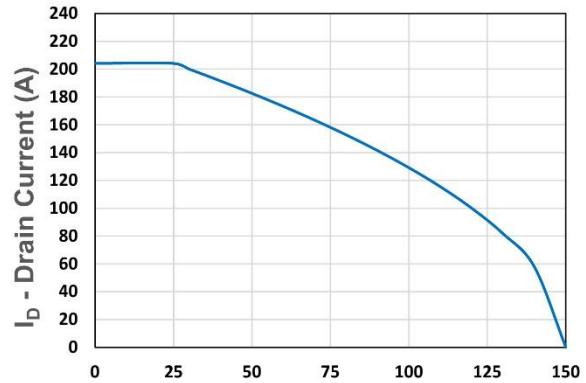
V<sub>DS</sub> - Drain - Source Voltage (V)  
Figure 7. Capacitance



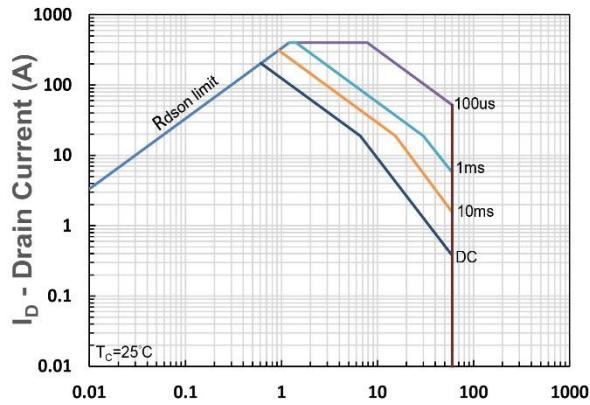
V<sub>GS</sub> (V)  
Q<sub>g</sub>, Total Gate Charge (nC)  
Figure 8. Gate Charge Characteristics



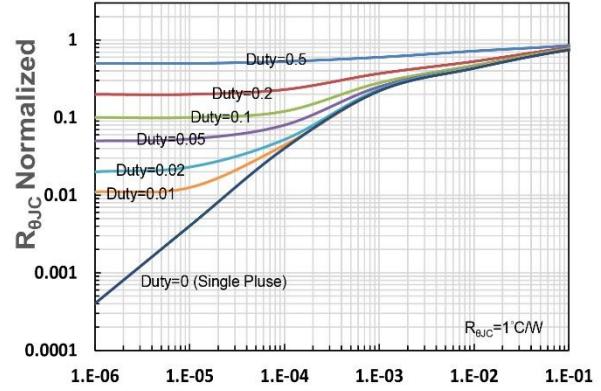
T<sub>c</sub> - Case Temperature (°C)  
Figure 9. Power Dissipation



I<sub>D</sub> - Drain Current (A)  
T<sub>c</sub> - Case Temperature (°C)  
Figure 10. Drain Current



V<sub>DS</sub> - Drain-Source Voltage (V)  
Figure 11. Safe Operating Area



t<sub>1</sub>, Square Wave Pulse Duration(s)  
Figure 12. R<sub>θJC</sub> Transient Thermal Impedance